

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10611418	MCKEAN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Goff, John L	1733

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
156	325,329	3/12/05	CS
Above	UPDATED	4/17/07	JLG
Above	UPDATED	10/5/07	JLG
Above	UPDATED	2/14/08	JLG

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	4/17/07	JLG
156/344,297 Updated search	4/17/07	JLG
156/344,297 Updated search	10/5/07	JLG
156/344,297 Updated search	2/14/08	JLG
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) - See Search History Printout	2/14/08	JLG

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>